

# DG139/142/145

## Dual DPDT JFET Analog Switches

### FEATURES

- ( $< 1 \mu\text{W}$ ) Standby Power
- Bipolar Drivers
- Constant  $r_{DS(ON)}$  Over Signal Range
- High Off Isolation ( $> 60 \text{ dB @ } 1 \text{ MHz}$ )

### BENEFITS

- Minimizes Standby Power Requirement
- Better Radiation Tolerance than CMOS
- Less Signal Distortion than CMOS
- Higher Frequency Switching

### APPLICATIONS

- Portable and Battery Powered Systems
- Switching in Satellite Applications
- Low Distortion Circuits
- High Frequency Switching Circuits

### DESCRIPTION

The DG139, DG142, and DG145 are precision dual double-pole double-throw analog switches designed for use in low distortion, high frequency circuits.

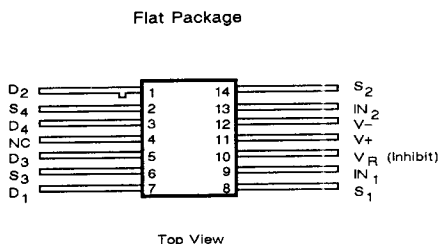
ON resistance of the DG139 is  $< 30 \Omega$ , the DG142  $< 80 \Omega$  and the DG145 is  $< 10 \Omega$  and ON shunt leakage for all three is  $< 2 \text{ nA}$ . With both drivers in the "switch OFF" state, total power consumption is  $< 750 \mu\text{W}$ . By using the JFET process, all three analog switches are relatively radiation tolerant.

The DG139, DG142 and DG145 each contain four junction-type field-effect transistors (JFETs) designed to function as two double-pole double-throw electronic switches. Level-shifting drivers enable low-level inputs (2 V to 3 V) to control the ON-OFF state of the switches. The driver inputs are connected differentially, therefore with

input IN2 connected to a 2.5 voltage reference, a positive logic "0" at the input IN1 will turn switches 1 and 3 OFF and switches 2 and 4 ON. A positive logic "1" at IN1 will turn switches 1 and 3 ON and switches 2 and 4 OFF. The normally grounded  $V_R$  terminal may be used as an "inhibit" terminal, in which case all switches may be held OFF with a positive voltage applied to  $V_R$ . In the ON state each switch conducts equally well in either direction, and in the OFF state each switch will block voltages up to 20 V peak-to-peak.

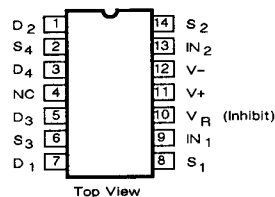
Packaging for this series includes the 14-pin side braze and flatpack options. Performance grades include both a military, A suffix ( $-55$  to  $125^\circ\text{C}$ ) and industrial, B suffix ( $-25$  to  $85^\circ\text{C}$ ) temperature range. The flatpack option is only available in the military grade.

### PIN CONFIGURATION



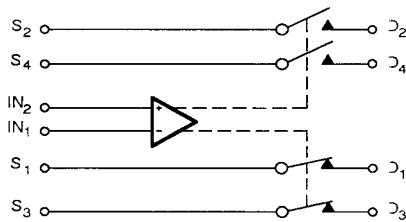
Order Numbers:  
DG139AL/883, DG142AL/883  
DG145AL/883

Dual-In-Line Package



Order Numbers:  
DG139AP, DG139BP  
DG142AP, DG142BP

**FUNCTIONAL BLOCK DIAGRAM**



Two DPDT Switches per Package\*

Truth Table

Logic	SW1 SW3	SW2 SW4
0	OFF	ON
1	ON	OFF

\*Switches Shown for Logic "1" Input at IN<sub>1</sub> and a 2.5 V reference at IN<sub>2</sub>

**ABSOLUTE MAXIMUM RATINGS**

V <sub>+</sub> to V <sub>-</sub> , V <sub>D</sub> or V <sub>S</sub>	±6 V
V <sub>D</sub> or V <sub>S</sub> to V <sub>-</sub>	±6 V
V <sub>D</sub> to V <sub>S</sub>	±2 V
V <sub>+</sub> to V <sub>R</sub>	±5 V
V <sub>+</sub> to V <sub>IN1</sub> or V <sub>IN2</sub>	±5 V
V <sub>R</sub> to V <sub>-</sub>	±5 V
V <sub>IN1</sub> to V <sub>IN2</sub>	±6 V
V <sub>IN1</sub> or V <sub>IN2</sub> to V <sub>R</sub>	±6 V
V <sub>IN1</sub> or V <sub>IN2</sub> to V <sub>-</sub>	±0 V

Current, (Any Terminal)	30 mA
Storage Temperature	-65 to 150°C
Operating Temperature (A Suffix)	-55 to 125°C
(B Suffix)	-25 to 85°C

Power Dissipation\*

Flat Package**	750 mW
14-Pin DIP***	825 mW

\* All leads welded or soldered to PC board.

\*\* Derate 10 mW/°C above 75°C.

\*\*\* Derate 11 mW/°C above 75°C.

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ELECTRICAL CHARACTERISTICS <sup>a</sup>							DG139			
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V <sub>+</sub> = 12 V V <sub>-</sub> = -18 V V <sub>R</sub> = 0 V <sub>IN2</sub> = 2.5 V	LIMITS						UNIT	
			1=25°C		A SUFFIX -55 to 125°C		B SUFFIX -25 to 85°C			
			TEMP	TYP <sup>d</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>		
<b>SWITCH</b>										
Analogue Signal Range <sup>c</sup>	V <sub>ANALOG</sub>		1, 2, 3		-10	10	-8	8	V	
Drain-Source ON Resistance	r <sub>DS(ON)</sub>	I <sub>S</sub> = -10 mA V <sub>IN1</sub> = 3 V (SW1, 3 ON) V <sub>IN1</sub> = 2 V (SW2, 4 ON)	V <sub>D</sub> = 10 V	1, 3 2	20		30 60		Ω	
		V <sub>D</sub> = 8 V	1, 3 2	35		50 75				
Source OFF Leakage Current	I <sub>S(OFF)</sub>	V <sub>IN1</sub> = 2 V (SW1, 3 OFF) V <sub>IN1</sub> = 3 V (SW2, 4 OFF)	V <sub>S</sub> = 10 V V <sub>D</sub> = -10 V	1 2	0.15		1 100		nA	
			V <sub>S</sub> = 8 V V <sub>D</sub> = -8 V	1 2	0.75		5 100			

**Not Recommended for New Designs**

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ELECTRICAL CHARACTERISTICS <sup>a</sup>								DG139		
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V <sub>+</sub> = 12 V V <sub>-</sub> = -18 V V <sub>R</sub> = 0 V <sub>IN2</sub> = 2.5 V		LIMITS						
				1=25°C		A SUFFIX		B SUFFIX		
				2=125,85°C		-55 to 125°C		-25 to 85°C		
				TEMP	TYP <sup>d</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	UNIT
<b>SWITCH (Cont'd)</b>										
Drain OFF Leakage Current	I <sub>D(OFF)</sub>	V <sub>IN1</sub> = 2 V (SW1, 3 OFF)	V <sub>D</sub> = 10 V V <sub>S</sub> = -10 V	1 2	0.03		1 100			nA
		V <sub>IN1</sub> = 3 V (SW2, 4 OFF)	V <sub>D</sub> = 8 V V <sub>S</sub> = -8 V	1 2	0.15			5 100		
Channel ON Leakage Current	I <sub>D(ON)</sub> + I <sub>S(ON)</sub>	V <sub>IN1</sub> = 3 V (SW1, 3 ON)	V <sub>D</sub> = V <sub>S</sub> = -10 V	1 2	-0.05	-2 -100				nA
		V <sub>IN1</sub> = 2 V (SW2, 4 ON)	V <sub>D</sub> = V <sub>S</sub> = -8 V	1 2	-0.12			-5 -100		
<b>INPUT</b>										
Input 1 Current Input 1 Voltage LOW	I <sub>IN1L</sub>	V <sub>IN1</sub> = 2 V		1,3 2	0.001		0.1 2		4 4	μA
Input 2 Current Input 2 Voltage LOW	I <sub>IN2L</sub>	V <sub>IN2</sub> = 2 V, V <sub>IN1</sub> = 2.5 V		1,3 2	0.001		0.1 2		4 4	
Input 1 Current Input 1 Voltage HIGH	I <sub>IN1H</sub>	V <sub>IN1</sub> = 3 V		1,2 3	20		60 120		100 150	
Input 2 Current Input 2 Voltage HIGH	I <sub>IN2H</sub>	V <sub>IN2</sub> = 3 V, V <sub>IN1</sub> = 2.5 V		1,2 3	20		60 120		100 150	
<b>DYNAMIC</b>										
Turn-ON Time	t <sub>ON</sub>	See Switching Time Test Circuit <sup>e</sup>		1			0.8		1	μs
Turn-OFF Time	t <sub>OFF</sub>			1			1.6		2	
Drain-OFF Capacitance	C <sub>D(OFF)</sub>	f = 1 MHz	V <sub>D</sub> = 0 V I <sub>S</sub> = 0	1	2.4					pF
Source-OFF Capacitance	C <sub>S(OFF)</sub>		V <sub>S</sub> = 0 V I <sub>D</sub> = 0	1	2.4					
Channel-ON Capacitance	C <sub>D(ON)</sub> + C <sub>S(ON)</sub>		V <sub>D</sub> = V <sub>S</sub> = 0 V	1	2.8					
OFF Isolation	OIRR	R <sub>L</sub> = 75 Ω, f = 1 MHz		1	>60					dB
<b>SUPPLY</b>										
Positive Supply Current	I <sub>+</sub>	One Channel ON V <sub>IN1</sub> = 2 V or V <sub>IN1</sub> = 3 V		1	2.6		4.2		4.5	mA
Negative Supply Current	I <sub>-</sub>			1	-1.3	-2		-2.2		
Reference Supply Current	I <sub>R</sub>			1	-1.4	-2.2		-2.4		

ELECTRICAL CHARACTERISTICS <sup>a</sup>								DG139	
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V <sub>+</sub> = 12 V V <sub>-</sub> = -18 V V <sub>R</sub> = 0 V <sub>IN2</sub> = 2.5 V	LIMITS						UNIT
			1=25°C		A SUFFIX		B SUFFIX		
			TEMP	TYP <sup>d</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	
<b>SUPPLY (Cont'd)</b>									
Positive Supply Current	I <sub>+</sub>	All Channels OFF V <sub>IN1</sub> = V <sub>IN2</sub> = 0.8 V	1	0.75		25		25	μA
Negative Supply Current	I <sub>-</sub>		1	-1	-25		-25		
Reference Supply Current	I <sub>R</sub>		1	-0.2	-25		-25		

ELECTRICAL CHARACTERISTICS <sup>a</sup>								DG142	
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V <sub>+</sub> = 12 V V <sub>-</sub> = -18 V V <sub>R</sub> = 0 V <sub>IN2</sub> = 2.5 V	LIMITS						UNIT
			1=25°C		A SUFFIX		B SUFFIX		
			TEMP	TYP <sup>d</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	
<b>SWITCH</b>									
Analog Signal Range <sup>c</sup>	V <sub>ANALOG</sub>		1,2,3		-10	10	-8	8	V
Drain-Source ON Resistance	r <sub>DS(ON)</sub>	I <sub>S</sub> = -10 mA V <sub>IN1</sub> = 3 V (SW1, 3 ON)	V <sub>D</sub> = 10 V	1,3 2	30		80 150		Ω
		V <sub>IN1</sub> = 2 V (SW2, 4 ON)	V <sub>D</sub> = 8 V	1,3 2	35			100 150	
Source OFF Leakage Current	I <sub>S(OFF)</sub>	V <sub>IN1</sub> = 2 V (SW1, 3 OFF)	V <sub>S</sub> = 10 V V <sub>D</sub> = -10 V	1 2	0.01		1 100		nA
		V <sub>IN1</sub> = 3 V (SW2, 4 OFF)	V <sub>S</sub> = 8 V V <sub>D</sub> = -8 V	1 2	0.05			5 100	
Drain OFF Leakage Current	I <sub>D(OFF)</sub>	V <sub>IN1</sub> = 2 V (SW1, 3 OFF)	V <sub>D</sub> = 10 V V <sub>S</sub> = -10 V	1 2	0.005		1 100		nA
		V <sub>IN1</sub> = 3 V (SW2, 4 OFF)	V <sub>D</sub> = 8 V V <sub>S</sub> = -8 V	1 2	0.025			5 100	
Channel ON Leakage Current	I <sub>D(ON)</sub> + I <sub>S(ON)</sub>	V <sub>IN1</sub> = 3 V (SW1, 3 ON)	V <sub>D</sub> = V <sub>S</sub> = -10 V	1 2	-0.02	-2 100			nA
		V <sub>IN1</sub> = 2 V (SW2, 4 ON)	V <sub>D</sub> = V <sub>S</sub> = -8 V	1 2	-0.05			-5 -100	

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**Not Recommended for New Designs**

ELECTRICAL CHARACTERISTICS <sup>a</sup>										DG142
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V <sub>+</sub> = 12 V V <sub>-</sub> = -18 V V <sub>R</sub> = 0 V <sub>IN2</sub> = 2.5 V	LIMITS						UNIT	
			1=25°C 2=125,85°C 3=-55,-25°C		A SUFFIX -55 to 125°C		B SUFFIX -25 to 85°C			
			TEMP	TYP <sup>d</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>		
<b>INPUT</b>										
Input 1 Current Input 1 Voltage LOW	I <sub>IN1L</sub>	V <sub>IN1</sub> = 2 V	1,3 2	0.0005		0.1 2		4 4	μA	
Input 2 Current Input 2 Voltage LOW	I <sub>IN2L</sub>	V <sub>IN2</sub> = 2 V, V <sub>IN1</sub> = 2.5 V	1,3 2	0.001		0.1 2		4 4		
Input 1 Current Input 1 Voltage HIGH	I <sub>IN1H</sub>	V <sub>IN1</sub> = 3 V	1,2 3	25		60 120		100 150		
Input 2 Current Input 2 Voltage HIGH	I <sub>IN2H</sub>	V <sub>IN2</sub> = 3 V, V <sub>IN1</sub> = 2.5 V	1,2 3	25		60 120		100 150		
<b>DYNAMIC</b>										
Turn-ON Time	t <sub>ON</sub>	See Switching Time Test Circuit <sup>e</sup>	1	0.5		0.8		1	μs	
Turn-OFF Time	t <sub>OFF</sub>		1	1.1		1.6		2.0		
Drain-OFF Capacitance	C <sub>D(OFF)</sub>	f = 1 MHz	1	2.4					pF	
Source-OFF Capacitance	C <sub>S(OFF)</sub>									V <sub>D</sub> = 0 V I <sub>S</sub> = 0
Channel-ON Capacitance	C <sub>D(ON)</sub> + C <sub>S(ON)</sub>									V <sub>S</sub> = 0 V I <sub>D</sub> = 0
Channel-ON Capacitance		V <sub>D</sub> = V <sub>S</sub> = 0 V	1	2.8						
OFF Isolation	OIRR	R <sub>L</sub> = 75 Ω, f = 1 MHz	1	>60					dB	
<b>SUPPLY</b>										
Positive Supply Current	I <sub>+</sub>	One Channel ON V <sub>IN1</sub> = 2 V, V <sub>IN1</sub> = 3 V	1	2.6		4.2		4.5	mA	
Negative Supply Current	I <sub>-</sub>		1	-1.3	-2		-2.2			
Reference Supply Current	I <sub>R</sub>		1	-1.4	-2.2		-2.4			
Positive Supply Current	I <sub>+</sub>	All Channels OFF V <sub>IN1</sub> = V <sub>IN2</sub> = 0.8 V	1	0.75		25		25	μA	
Negative Supply Current	I <sub>-</sub>		1	-1	-25		-25			
Reference Supply Current	I <sub>R</sub>		1	-0.2	-25		-25			

ELECTRICAL CHARACTERISTICS <sup>a</sup>										DG145
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: $V_+ = 12\text{ V}$ $V_- = -18\text{ V}$ $V_R = 0$ $V_{IN2} = 2.5\text{ V}$		LIMITS						UNIT
				1=25°C		A SUFFIX		B SUFFIX		
				TEMP	TYP <sup>d</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	
<b>SWITCH</b>										
Analog Signal Range <sup>c</sup>	$V_{ANALOG}$			1, 2, 3		-10	10	-8	8	V
Drain-Source ON Resistance	$r_{DS(ON)}$	$I_S = -10\text{ mA}$ $V_{IN1} = 3\text{ V}$ (SW1, 3 ON) $V_{IN1} = 2\text{ V}$ (SW2, 4 ON)	$V_D = 10\text{ V}$	1, 3 2	7		10 20			$\Omega$
			$V_D = 8\text{ V}$	1, 3 2				15 25		
Source OFF Leakage Current	$I_{S(OFF)}$	$V_{IN1} = 2\text{ V}$ (SW1, 3 OFF) $V_{IN1} = 3\text{ V}$ (SW2, 4 OFF)	$V_S = 10\text{ V}$ $V_D = -10\text{ V}$	1 2	0.1		10 1000			nA
			$V_S = 8\text{ V}$ $V_D = -8\text{ V}$	1 2				15 300		
Drain OFF Leakage Current	$I_{D(OFF)}$	$V_{IN1} = 2\text{ V}$ (SW1, 3 OFF) $V_{IN1} = 3\text{ V}$ (SW2, 4 OFF)	$V_D = 10\text{ V}$ $V_S = -10\text{ V}$	1 2	0.1		10 1000			nA
			$V_D = 8\text{ V}$ $V_S = -8\text{ V}$	1 2				15 300		
Channel ON Leakage Current	$I_{D(ON)} + I_{S(ON)}$	$V_{IN1} = 3\text{ V}$ (SW1, 3 ON) $V_{IN1} = 2\text{ V}$ (SW2, 4 ON)	$V_D = V_S = -10\text{ V}$	1 2	-0.04	-2 100				nA
			$V_D = V_S = -8\text{ V}$	1 2				-5 -100		
<b>INPUT</b>										
Input 1 Current Input 1 Voltage LOW	$I_{IN1L}$	$V_{IF1} = 2\text{ V}$		1, 3 2	0.001		0.1 2		4 4	$\mu\text{A}$
Input 2 Current Input 2 Voltage LOW	$I_{IN2L}$	$V_{IN2} = 2\text{ V}, V_{IN1} = 2.5\text{ V}$		1, 3 2	0.001		0.1 2		4 4	
Input 1 Current Input 1 Voltage HIGH	$I_{IN1H}$	$V_{IF1} = 3\text{ V}$		1, 2 3	20		60 120		100 150	
Input 2 Current Input 2 Voltage HIGH	$I_{IN2H}$	$V_{IN2} = 3\text{ V}, V_{IN1} = 2.5\text{ V}$		1, 2 3	20		60 120		100 150	
<b>DYNAMIC</b>										
Turn-ON Time	$t_{ON}$	See Switching Time Test Circuit <sup>e</sup>		1	0.5		1		1.5	$\mu\text{s}$
Turn-OFF Time	$t_{OFF}$			1	1.2		2.5		2.5	
Drain-OFF Capacitance	$C_{D(OFF)}$	f = 1 MHz	$V_D = 0\text{ V}$ $I_S = 0$	1	3					pF
Source-OFF Capacitance	$C_{S(OFF)}$		$V_S = 0\text{ V}$ $I_D = 0$	1	3					
Channel-ON Capacitance	$C_{D(ON)} + C_{S(ON)}$		$V_D = V_S = 0$	1	2.8					

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**Not Recommended for New Designs**

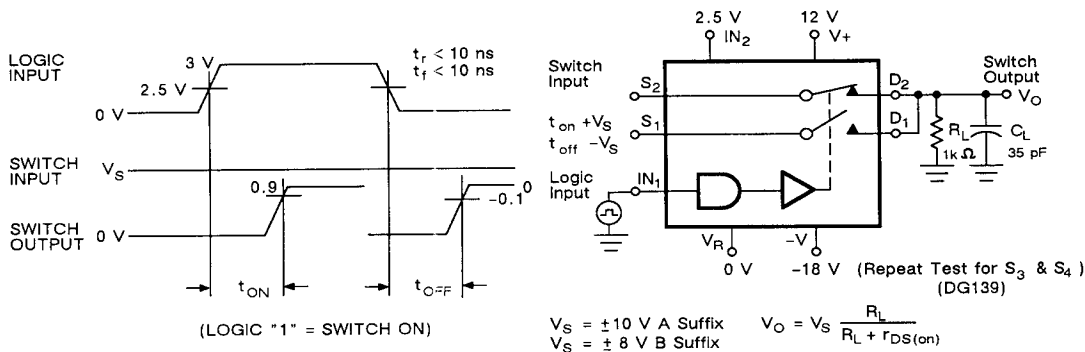
ELECTRICAL CHARACTERISTICS <sup>a</sup>								DG145		
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V <sub>+</sub> = 12 V V <sub>-</sub> = -18 V V <sub>R</sub> = 0 V <sub>IN2</sub> = 2.5 V	LIMITS						UNIT	
			1=25°C		A SUFFIX		B SUFFIX			
			TEMP	TYP <sup>d</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>	MIN <sup>b</sup>	MAX <sup>b</sup>		
<b>DYNAMIC (Cont'd)</b>										
OFF Isolation	OIRR	R <sub>L</sub> = 75 Ω, f = 1 MHz	1	>50						dB
<b>SUPPLY</b>										
Positive Supply Current	I <sub>+</sub>	One Channel ON V <sub>IN1</sub> = 2 V, V <sub>IN1</sub> = 3 V	1	2.6		4.2		4.5	mA	
Negative Supply Current	I <sub>-</sub>		1	-1.2	-2		-2.2			
Reference Supply Current	I <sub>R</sub>		1	-1.4	-2.2		-2.4			
Positive Supply Current	I <sub>+</sub>	All Channels OFF V <sub>IN1</sub> = V <sub>IN2</sub> = 0.8 V	1	0.75		25		25	μA	
Negative Supply Current	I <sub>-</sub>		1	-1	-25		-25			
Reference Supply Current	I <sub>R</sub>		1	-0.2	-25		-25			

**NOTES:**

- a. Refer to PROCESS OPTION FLOWCHART for additional information.
- b. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- c. Guaranteed by design, not subject to production test.
- d. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- e. V<sub>IN</sub> must be a step function with a minimum rise and fall time of 1 V/μs.

**SWITCHING TIME TEST CIRCUIT**

Switch output waveform shown for V<sub>S</sub> = constant with logic input waveform as shown. Note that V<sub>S</sub> may be + or - as per switching time test circuit. V<sub>O</sub> is the steady state output with switch ON. Feedthrough via gate capacitance may result in spikes at leading and trailing edge of output waveform.



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**APPLICATION HINTS**


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V+ Positive Supply Voltage (V)	V- Negative Supply Voltage (V)	V <sub>R</sub> Reference Voltage (V)	V <sub>IN1</sub> Input 1 Voltage V <sub>INH</sub> / V <sub>INL</sub> (V)	V <sub>IN2</sub> Input 2 Voltage (V)	V <sub>S</sub> or V <sub>D</sub> Analog Voltage Range (V)
12	-18	0	3/2	2.5	-10 to 10
15	-15	0	3/2	2.5	-5 to 13
5	-15	0	3/2	2.5	-5 to 3

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**Not Recommended for New Designs**

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